


<b>Search Notes</b>  	<b>Application/Control No.</b>  10536628	<b>Applicant(s)/Patent Under Reexamination</b>  HAJ-YEHIA ET AL.
	<b>Examiner</b>  YONG CHU	<b>Art Unit</b>  1626

SEARCHED			
Class	Subclass	Date	Examiner
514	422; 423	07/18/2008	YC
548	518; 530; 537	07/18/2008	YC

SEARCH NOTES		
Search Notes	Date	Examiner
STN	07/18/2008	YC
PALM/inventor name search	07/17/2008	YC
EAST	07/18/2008	YC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
514	422; 423	07/18/2008	YC
548	518; 530;537	07/18/2008	YC